## 10-BIT, 50MSPS, 50mW A/D CONVERTER

is 10 -bit $\mathrm{A} / \mathrm{D}$ converter in deep submicron CMOS technology
is Single supply voltage: 2.5 V
is Input range: 2Vpp differential
is 50 Msps sampling frequency
is Ultra low power consumption: 50 mW @ 50Msps
iv $\mathrm{ENOB}=9.6$ @ 40 Msps , Fin= 24 MHz
is SFDR typically up to 72 dB @ 50 Msps , Fin=5MHz
is Built-in reference voltage with external bias capability
is Pinout compatibility with TSA0801, TSA1001 and TSA1201

## DESCRIPTION

The TSA1002 is a 10 -bit, 50 Msps sampling frequency Analog to Digital converter using a CMOS technology combining high performances and very low power consumption.
The TSA1002 is based on a pipeline structure and digital error correction to provide excellent static linearity and guarantee 9.6 effective bits at $\mathrm{Fs}=40 \mathrm{Msps}$, and $\mathrm{Fin}=24 \mathrm{MHz}$.
A voltage reference is integrated in the circuit tc simplify the design and minimize exterr.al components. It is nevertheless possible to uie the circuit with an external reference.
Especially designed for high spfed, lows power applications, the TSA1002 only ciscipates 50 mW at 50 Msps . A tri-state capa'ili'v, available on the output buffers, enables o audress several slave ADCs by a unique misier.
The output date car be coded into two different formats. A D.tic Feady signal is raised as the data is valia (r, trie output and can be used for synchro, il:ation purposes.
Thこ TSA1002 is available in commercial (0 to 4) C) and extended ( -40 to +85 C) temperature range, in a small 48 pins TQFP package.

## APPLICATIONS

is Medical imaging and ultrasound
is Portable instrumentation
is Cable Modem Receivers
is High resolution fax and scanners
is High speed DSP interface

## ORDER CODE

| Part Number | Temperature <br> Range | Package | Conditioning | Marking |
| :--- | :---: | :---: | :---: | :---: |
| TSA1002CF | 0 C to +70 C | TQFP48 | Tray | SA1002C |
| TSA1002CFT | 0 C to +70 C | TQFP48 | Tape \& Reel | SA1002C |
| TSA10021F | -40 C to +85 C | TQFP48 | Tray | SA1002I |
| TSA1002IFT | -40 C to +85 C | TQFP48 | Tape \& Reel | SA10021 |
| EVAL1002/AA | Evaluation board |  |  |  |

PIN CONNECTIONS (top view)


## PACKAGE



## ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Values | Unit |
| :---: | :--- | :---: | :---: |
| AVCC | Analog Supply voltage 1) | 0 to 3.3 |  |
| DVCC | Digital Supply voltage 1) | 0 to 3.3 | V |
| VCCB | Digital buffer Supply voltage 1) | 0 to 3.3 | V |
| IDout | Digital output current | -100 to 100 | V |
| Tstg | Storage temperature | $\mathrm{+150}$ | mA |
| ESD | Electrical Static Discharge |  | C |
|  | 2 | KV |  |
|  | Class $^{2}$ CDM-JEDEC Standard | 1.5 | KV |

1) All voltages values, except differential voltage, are with respect to network ground terminal. The magnitude of input and output voltages must never exceed -0.3 V or $\mathrm{VCC}+0 \mathrm{~V}$
2) Corporate ST Microelectronics procedure number 0018695

OPERATING CONDITIONS

| Symbol | Parameter | Min | Typ | Max | Unit |
| :---: | :--- | :---: | :---: | :---: | :---: |
| AVCC | Analog Supply voltage | 2.25 | 2.5 | 2.7 | V |
| DVCC | Digital Supply voltage | 2.25 | 2.5 | 2.7 | V |
| VCCB | Digital buffer Supply voltage | 2.25 | 2.5 | 2.7 | V |
| VREFP | Forced top reference voltage ${ }^{1)}$ | 0.5 | 1 | 1.8 | V |
| VREFM | Forced bottom reference voltage ${ }^{1)}$ | 0 | 0 | 0.5 | V |
| INCM | Forced input common mode voltage | 0.2 | 0.5 | 1.1 | V |

1)Condition VRefP-VRefM>0.3V

## BLOCK DIAGRAM



PIN CONNECTIONS (top view)


## PIN DESCRIPTION

| Pin No | Name | Description | Observation | Pin No | Name | Description | Observation |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | IPOL | Analog bias current input |  | 25 | D8 | Digital output | CMOS output (2.5V) |
| 2 | VREFP | Top voltage reference | 1V | 26 | D7 | Digital output | CMOS output (2.5V) |
| 3 | VREFM | Bottom voltage reference | OV | 27 | D6 | Digital output | CMOS output (2.5V) |
| 4 | AGND | Analog ground | OV | 28 | D5 | Digital output | CMOS output (2.5V) |
| 5 | VIN | Analog input | 1Vpp | 29 | D4 | Digital output | CMOS output (2.5V) |
| 6 | AGND | Analog ground | OV | 30 | D3 | Digital output | CMOS output (2.5V) |
| 7 | VINB | Inverted analog input | 1Vpp | 31 | D2 | Digital output | CMOS output (2.5V) |
| 8 | AGND | Analog ground | OV | 32 | D1 | Digital output | CMOS output (2.5V) |
| 9 | INCM | Input common mode | 0.5 V | 33 | D0(LSB) | Least Significant Bit output | CMOS output (2.5V) |
| 10 | AGND | Analog ground | OV | 34 | NC | Non connected |  |
| 11 | AVCC | Analog power supply | 2.5 V | 35 | NC | Non connected |  |
| 12 | AVCC | Analog power supply | 2.5 V | 36 | NC | Non connected |  |
| 13 | DVCC | Digital power supply | 2.5 V | 37 | NC | Non connected |  |
| 14 | DVCC | Digital power supply | 2.5 V | 38 | DR | Data Ready output | CMOS output (2.5V) |
| 15 | DGND | Digital ground | 0 V | 39 | VCCB | Digital Buffer power supply | 2.5 V |
| 16 | CLK | Clock input | 2.5 V compatible CMOS input | 40 | GNDB | Digital Buffer ground | OV |
| 17 | DGND | Digital ground | OV | 41 | VCCB | Digital Buffer power supply | 2.5 V |
| 18 | NC | Non connected |  | 42 | NC | Non connected |  |
| 19 | DGND | Digital ground | OV | 43 | NC | Non connected |  |
| 20 | GNDB | Digital buffer ground | OV | 44 | OEB | Output Enable input | 2.5 V compatible CMOS input |
| 21 | GNDB | Digital buffer ground | OV | 45 | DFSB | Data Format Select input | 2.5 V compatible CMOS input |
| 22 | VCCB | Digital buffer power supply | 2.5 V | 46 | AVCC | Analog power supply | 2.5 V |
| 23 | OR | Out Of Range output | CMOS output (2.5V) | 47 | AVCC | Analog power supply | 2.5 V |
| 24 | D9(MSB) | Most Significant Bit output | CMOS output (2.5V) | 48 | AGND | Analog ground | OV |

## ELECTRICAL CHARACTERISTICS

AVCC $=\mathrm{DVCC}=\mathrm{VCCB}=2.5 \mathrm{~V}, \mathrm{Fs}=40 \mathrm{Msps}, F i n=1 \mathrm{MHz}, \mathrm{Vin} @-1.0 \mathrm{dBFS}, \mathrm{VREFM}=0 \mathrm{~V}$
Tamb $=25 \mathrm{C}$ (unless otherwise specified)

## timing Characteristics

| Symbol | Parameter | Test conditions | Min | Typ | Max | Unit |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| FS | Sampling Frequency |  | 0.5 |  | 50 | Msps |
| DC | Clock Duty Cycle |  | 40 | 50 | 60 | $\%$ |
| TC1 | Clock pulse width (high) |  | 9 | 10 |  | ns |
| TC2 | Clock pulse width (low) |  | 9 | 10 |  | ns |
| Tod | Data Output Delay (Fall of Clock <br> to Data Valid) | 10pF load capacitance | 5 |  | ns |  |
| Tpd | Data Pipeline delay |  |  | 5.5 |  | cycles |
| Ton | Falling edge of OEB to digital <br> output valid data |  | 1 |  | ns |  |
| Toff | Rising edge of OEB to digital <br> output tri-state |  |  | ns |  |  |

## TIMING DIAGRAM



## CONDITIONS

$\mathrm{AVCC}=\mathrm{DVCC}=\mathrm{VCCB}=2.5 \mathrm{~V}, \mathrm{Fs}=40 \mathrm{Msps}, \mathrm{Fin}=1 \mathrm{MHz}, \mathrm{Vin} @-1.0 \mathrm{dBFS}, \mathrm{VREFM}=0 \mathrm{~V}$ Tamb $=25 \mathrm{C}$ (unless otherwise specified)

## ANALOG INPUTS

| Symbol | Parameter | Test conditions | Min | Typ | Max | Unit |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| VIN-VINB | Full scale reference voltage |  |  | 2.0 |  | Vpp |
| Req | Equivalent input resistance |  |  | 13 |  | $\mathrm{k} \Omega$ |
| Cin | Input capacitance |  |  | 5.0 |  | pF |
| BW | Analog Input Bandwidth | Vin@ Full scale, FS=50Msps |  | 1000 |  | MHz |
| ERB | Effective Resolution Bandwidth ${ }^{1)}$ |  |  | 60 |  | MHz |

1) See parameters definition for more information

## REFERENCE VOLTAGE

| Symbol | Parameter | Test conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| VREFP | Top internal reference voltage | $\cdots$ | 0.91 | 1.03 | 1.14 | V |
|  |  | Tmin $=-40 \mathrm{C}$ to Tmax $=85 \mathrm{C}^{1}$ | 0.88 |  | 1.16 | V |
| Vpol | Analog bias voltage |  | 1.20 | 1.27 | 1.35 | V |
|  |  | Tmin $=-40 \mathrm{C}$ to $\operatorname{Tmax}=85 \mathrm{C}^{1)}$ | $1.18$ |  | 1.36 | V |
| Ipol | Analog bias current | Normal operating mode | 50 | 70 | 100 | $\mu \mathrm{A}$ |
| Ipol | Analog bias current | Shutdown mode |  | 0 |  | $\mu \mathrm{A}$ |
| VINCM | Input common mode voltage | $5$ | 0.47 | 0.57 | 0.68 | V |
|  |  | Tmin $=-40 \mathrm{C}$ to Tmax $=85 \mathrm{C}^{1)}$ | 0.46 |  | 0.66 | V |

1) Not fully tested over the temperature range. Guaranteed by sampling.

## CONDITIONS

$\mathrm{AVCC}=\mathrm{DVCC}=\mathrm{VCCB}=2.5 \mathrm{~V}, \mathrm{Fs}=40 \mathrm{Msps}, \mathrm{Fin}=1 \mathrm{MHz}, \mathrm{Vin} @-1.0 \mathrm{dBFS}, \mathrm{VREFP}=1 \mathrm{~V}, \mathrm{VREFM}=0 \mathrm{~V}$ Tamb $=25 \mathrm{C}$ (unless otherwise specified)

## POWER CONSUMPTION

| Symbol | Parameter | Test conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ICCA | Analog Supply current | 1) |  | 15.6 | 18 | mA |
|  |  | Tmin $=-40 \mathrm{C}$ to $\operatorname{Tmax}=85 \mathrm{C}^{2}$ |  |  | 21 | mA |
| ICCD | Digital Supply Current | 1) |  | 1.3 | 2 | mA |
|  |  | Tmin $=-40 \mathrm{C}$ to $\operatorname{Tmax}=85 \mathrm{C}^{2}$ |  |  | 2 | mA |
| ICCB | Digital Buffer Supply Current | 1) |  | 2.5 | 5 | mA |
|  |  | Tmin $=-40 \mathrm{C}$ to $\operatorname{Tmax}=85 \mathrm{C}^{2}$ |  |  | 5 | mA |
| ICCBZ | Digital Buffer Supply Current in High Impedance Mode |  |  | 40 | 100 | $\mu \mathrm{A}$ |
| Pd | Power consumption in normal operation mode |  |  | 48 | 60 | mW |
|  |  | Tmin $=-40 \mathrm{C}$ to $\operatorname{Tmax}=85 \mathrm{C}^{2)}$ |  |  | 62 | mW |
| PdZ | Power consumption in High Impedance mode |  |  | 43 | 48 | mW |
| Rthja | Junction-ambient thermal resistor (TQFP48) |  |  | 80 |  | C/W |

1) Rpol= $18 \mathrm{~K} \Omega$. Equivalent load: Rload $=470 \Omega$ and Cload= 6 pF
2) Not fully tested over the temperature range. Guaranteed by sampling.

## DIGITAL INPUTS AND OUTPUTS

| Symbol | Parameter | Test conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Digital inputs |  | C) |  |  |  |  |
| VIL | Logic "0" voltage | - |  |  | 0.8 | V |
| VIH | Logic "1" voltage |  | 2.0 |  |  | V |
| Digital Outputs |  |  |  |  |  |  |
| VOL | Logic "0" voltage | $\mathrm{lol}=10 \mu \mathrm{~A}$ |  |  | 0.4 | V |
| VOH | Logic "1" voltage | $\mathrm{loh}=-10 \mu \mathrm{~A}$ | 2.4 |  |  | V |
| IOZ | High Impedance leakage current | OEB set to VIH | -1.5 |  | 1.5 | $\mu \mathrm{A}$ |
| $C_{L}$ | Output Load Capacitance |  |  |  | 15 | pF |

## ACCURACY

| Symbol | Parameter | Test conditions | Min | Typ | Max | Unit |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| OE | Offset Error | Fin $=2 M H z$, VIN@+1dBFS | -40 | -2 | 40 | mV |
| DNL | Differential Non Linearity | Fin $=2 M H z$, VIN@ +1 dBFS | -0.7 | $\pm 0.2$ | +0.7 | LSB |
| INL | Integral Non Linearity | Fin $=2 M H z$, VIN@+1dBFS | -0.8 | $\pm 0.3$ | +0.8 | LSB |
| - | Monotonicity and no missing <br> codes |  | Guaranteed |  |  |  |

CONDITIONS
$\mathrm{AVCC}=\mathrm{DVCC}=2.5 \mathrm{~V}, \mathrm{Fs}=40 \mathrm{Msps} \mathrm{Vin} @-1.0 \mathrm{dBFS}, \mathrm{VREFP}=1 \mathrm{~V}, \mathrm{VREFM}=0 \mathrm{~V}$
Tamb $=25 \mathrm{C}$ (unless otherwise specified)
DYNAMIC CHARACTERISTICS

| Symbol | Parameter | Tes | onditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SFDR | Spurious Free Dynamic Range | $\begin{aligned} & \text { Fin }=5 \mathrm{MHz} \\ & \mathrm{Fin}=10 \mathrm{MHz} \\ & \mathrm{Fin}=24 \mathrm{MHz} \end{aligned}$ | 1) |  | $\begin{gathered} -79.2 \\ -77 \\ -69 \end{gathered}$ | $\begin{aligned} & -65.5 \\ & -68.5 \\ & -63.4 \end{aligned}$ | dBc |
|  |  | $\begin{aligned} & \text { Fin }=5 \mathrm{MHz} \\ & \text { Fin }=10 \mathrm{MHz} \\ & \text { Fin }=24 \mathrm{MHz} \end{aligned}$ | 2) |  |  | $\begin{aligned} & \hline-61.5 \\ & -62.8 \\ & -58.5 \end{aligned}$ | dBc |
| SNR | Signal to Noise Ratio | $\begin{aligned} & \text { Fin }=5 \mathrm{MHz} \\ & \mathrm{Fin}=10 \mathrm{MHz} \\ & \mathrm{Fin}=24 \mathrm{MHz} \end{aligned}$ | 1) | $\begin{aligned} & 58.5 \\ & 58.3 \\ & 57.4 \end{aligned}$ | $\begin{aligned} & \hline 59.5 \\ & 59.4 \\ & 59.0 \end{aligned}$ |  | dB |
|  |  | $\begin{aligned} & \text { Fin }=5 \mathrm{MHz} \\ & \mathrm{Fin}=10 \mathrm{MHz} \\ & \text { Fin }=24 \mathrm{MHz} \end{aligned}$ | 2) | $\begin{aligned} & 57.9 \\ & 57.1 \\ & 55.9 \end{aligned}$ |  |  | dB |
| THD | Total Harmonic Distortion | $\begin{aligned} & \text { Fin }=5 \mathrm{MHz} \\ & \text { Fin }=10 \mathrm{MHz} \\ & \text { Fin }=24 \mathrm{MHz} \end{aligned}$ | 1) |  | $\begin{gathered} -77.8 \\ -76 \\ -68.1 \end{gathered}$ | $\begin{aligned} & \hline-63.5 \\ & -67.4 \\ & -62.5 \end{aligned}$ | dB |
|  |  | $\begin{aligned} & \text { Fin }=5 \mathrm{MHz} \\ & \mathrm{Fin}=10 \mathrm{MHz} \\ & \text { Fin }=24 \mathrm{MHz} \end{aligned}$ | 2) |  |  | $\begin{aligned} & \hline-62.3 \\ & -60.7 \\ & -57.6 \end{aligned}$ | dB |
| SINAD | Signal to Noise and Distortion Ratio | $\begin{aligned} & \text { Fin }=5 \mathrm{MHz} \\ & \text { Fin }=10 \mathrm{MHz} \\ & \text { Fin }=24 \mathrm{MHz} \end{aligned}$ | 1) | $\begin{aligned} & 58.5 \\ & 58.2 \\ & 57.0 \end{aligned}$ | $\begin{aligned} & 59.4 \\ & 59.3 \\ & 58.5 \end{aligned}$ |  | dB |
|  |  | $\begin{aligned} & \text { Fin }=5 \mathrm{MHz} \\ & \text { Fin }=10 \mathrm{MHz} \\ & \text { Fin }=24 \mathrm{MHz} \end{aligned}$ | 2) | $\begin{aligned} & \hline 57.8 \\ & 56.9 \\ & 55.3 \end{aligned}$ |  |  | dB |
| ENOB | Effective Number of Bits | $\begin{aligned} & \text { Fin }=5 \mathrm{MHz} \\ & \text { Fin }=10 \mathrm{MHz} \\ & \text { Fin }=24 \mathrm{MHz} \end{aligned}$ | 1) | $\begin{aligned} & 9.6 \\ & 9.5 \\ & 9.3 \end{aligned}$ | $\begin{aligned} & 9.76 \\ & 9.71 \\ & 9.60 \end{aligned}$ |  | bits |
|  |  | $\begin{aligned} & \text { Fin }=5 \mathrm{MHz} \\ & \text { Fin }=10 \mathrm{MHz} \\ & \text { Fin }=24 \mathrm{MHz} \end{aligned}$ | 2) | $\begin{gathered} \hline 9.4 \\ 9.3 \\ 9 \end{gathered}$ |  |  | bits |

1) $\mathrm{Rpol}=18 \mathrm{~K} \Omega$. Equivalent load: $\mathrm{Rload}=470 \Omega$ and $\mathrm{Cload}=6 \mathrm{pF}$
2) $\mathrm{Tmin}=-40 \mathrm{C}$ to $\mathrm{Tmax}=85 \mathrm{C}$. Not fully tested over the temperature range. Guaranteed by sampling.

## DEFINITIONS OF SPECIFIED PARAMETERS

## STATIC PARAMETERS

Static measurements are performed through method of histograms on a 2 MHz input signal, sampled at 40 Msps , which is high enough to fully characterize the test frequency response. The input level is +1 dBFS to saturate the signal.

## Differential Non Linearity (DNL)

The average deviation of any output code width from the ideal code width of 1 LSB.

## Integral Non linearity (INL)

An ideal converter presents a transfer function as being the straight line from the starting code to the ending code. The INL is the deviation for each transition from this ideal curve.

## DYNAMIC PARAMETERS

Dynamic measurements are performed by spectral analysis, applied to an input sine wave of various frequencies and sampled at 40 Msps .
The input level is -1 dBFS to measure the linear behavior of the converter. All the parameters are given without correction for the full scale amplitude performance except the calculated ENOB parameter.

## Spurious Free Dynamic Range (SFDR)

The ratio between the power of the worst spurious signal (not always an harmonic) and the amplitude of fundamental tone (signal power) over the full Nyquist band. It is expressed in dBc.

## Total Harmonic Distortion (THD)

The ratio of the rms sum of the first five harmonic distortion components to the rms value of the fundamental line. It is expressed in dB.

## Signal to Noise Ratio (SNR)

The ratio of the rms value of the fundamental component to the rms sum of all other spectral components in the Nyquist band ( $\mathrm{f}_{\mathrm{s}} / 2$ ) excluding DC, fundamental and the first five harmonics. SNR is reported in dB.

## Signal to Noise and Distortion Ratio (SINAD)

Similar ratio as for SNR but including the harmonic distortion components in the noise figure (not DC signal). It is expressed in dB.
From the SINAD, the Effective Number of Bits (ENOB) can easily be deduced using the formula: SINAD $=6.02 \times \mathrm{ENOB}+1.76 \mathrm{~dB}$.
When the applied signal is not Full Scale (FS), but has an $A_{0}$ amplitude, the SINAD expression becomes:
SINAD $_{2 A_{0}}=$ SINAD $_{\text {Full }}$ Scale $+20 \log \left(2 A_{0} /\right.$ FS $)$
$\operatorname{SINAD}_{2 A_{0}}=6.02 \times \mathrm{ENOB}+1.76 \mathrm{~dB}+20 \log \left(2 \mathrm{~A}_{0} /\right.$ FS)
The ENOB is expressed in bits.

## Analog Input Bandwidth

The maximum analog input frequency at which the spectral response of a full power signal is reduced by 3 dB . Higher values can be achieved with smaller input levels.

## Effective Resolution Bandwidth (ERB)

The band of input signal frequencies that the ADC is intended to convert without loosing linearity i.e. the maximum analog input frequency at which the SINAD is decreased by 3 dB or the ENOB by $1 / 2$ bit.

## Pipeline delay

Delay between the initial sample of the analog input and the availability of the corresponding digital data output, on the output bus. Also called data latency. It is expressed as a number of clock cycles.

## Static parameter: Integral Non Linearity

Fs=50MSPS; Fin=1MHz; Icc=20mA; N=131072pts


Static parameter: Differential Non Linearity
Fs=50MSPS; Fin=1MHz; Icc=20mA; $\mathrm{N}=131072 \mathrm{pts}$


## Linearity vs. Fs

Fin $=5 \mathrm{MHz}$; Rpol adjustment


## Distortion vs. Fs

Fin $=5 \mathrm{MHz}$; Rpol adjustment


## Linearity vs. Fs

Fin $=15 \mathrm{MHz}$; Rpol adjustment


Linearity vs. Fin
Fs=50MSPS; Icca=20mA


## Linearity vs.Temperature

Fs=50MSPS; Icca=20mA; Fin=5MHz


Distortion vs. Fs
Fin $=15 \mathrm{MHz}$; Rpol adjustment


Distortion vs. Fin
Fs=50MSPS; Icca=20mA


## Distortion vs. Temperature

Fs=50MSPS; Icca=20mA; Fin=5MHz;


## Linearity vs. AVcc

Fs=50MSPS; Icca=20mA; Fin=1MHz


## Linearity vs. DVcc

Fs=50MSPS; Icca=20mA; Fin=1MHz


Linearity vs. VccB
Fs=50MSPS; Icca=20mA; Fin=1MHz


Distortion vs. AVcc
Fs=50MSPS; Icca=20mA; Fin=1MHz


Distortion vs. DVcc
Fs=50MSPS; Icca=20mA; Fin=1MHz


Distortion vs. VccB
Fs=50MSPS; Icca=20mA; Fin=1MHz


## TSA1002 APPLICATION':'OTE

## DETAILED INFORMATION

The TSA1002 is a high speed analog to digital converter based on a pipeline architecture and the latest deep submicron CMOS process to achieve the best performances in terms of linearity and power consumption.
The pipeline structure consists of 9 internal conversion stages in which the analog signal is fed and sequentially converted into digital data.
Each 8 first stages consists of an Analog to Digital converter, a Digital to Analog converter, a Sample and Hold and a gain of 2 amplifier. A 1.5bit conversion resolution is achieved in each stage. The latest stage simply is a comparator. Each resulting LSB-MSB couple is then time shifted to recover from the conversion delay. Digital data correction completes the processing by recovering from the redundancy of the (LSB-MSB)
couple for each stage. The corrected data are outputted through the digital buffers.
Input signal is sampled on the rising edge of the clock while digital outputs are delivered on the falling edge of the Data Ready signal.
The advantages of such a converter reside in the combination of pipeline architecture and the most advanced technologies. The highest dynamic performances are achieved while consumption remains at the lowest level.
Some functionalities have been added in order to simplify as much as possible the application board. These operational modes are described in the following table.
The TSA1002 is pin to pin compatible with the 8bits/40Msps TSA0801, the 10bits/25Msps TSA1001 and the 12bits/50Msps TSA1201. This ensures a conformity within the product family and above all, an easy upgrade of the application.

## OPERATIONAL MODES DESCRIPTION

| Inputs |  |  |  |  | Outputs |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Analog input differential level |  |  | DFSB | OEB | OR | DR | Most Significant Bit (MSB) |
| (VIN-VINB) | > | RANGE | H | L | H | CLK | D9 |
| -RANGE | $>$ | (VIN-VINB) | H | L | H | CLK | D9 |
| RANGE> | (VIN-VINB) | >-RANGE | H | L | L | CLK | D9 |
| (VIN-VINB) | > | RANGE | L | L | H | CLK | Complemented D9 |
| -RANGE | > | (VIN-VINB) | L | L | H | CLK | Complemented D9 |
| RANGE> | (VIN-VINB) | >-RANGE | L | L | L | CLK | Complemented D9 |
|  | X |  | X | H | HZ | HZ | HZ |

## Data Format Select (DFSB)

When set to low level (VIL), the digital input DFSB provides a twoís complement digital output MSB. This can be of interest when performing some further signal processing.
When set to high level (VIH), DFSB provides a standard binary output coding.

## Output Enable (OEB)

When set to low level (VIL), all digital outputs remain active and are in low impedance state. When set to high level (VIH), all digital outputs buffers are in high impedance state. This results in lower consumption while the converter goes on sampling.

When OEB is set to low level again, the data is then valid on the output with a very short Ton delay.
The timing diagram page 4 summarizes this operating cycle.

## Out of Range (OR)

This function is implemented on the output stage in order to set up an "Out of Range" flag whenever the digital data is over the full scale range.
Typically, there is a detection of all the data being at ílí or all the data being at í1í. This ends up with an output signal OR which is in low level state (VOL) when the data stay within the range, or in high level state $(\mathrm{VOH})$ when the data are out of the range.

## Data Ready (DR)

The Data Ready output is an image of the clock being synchronized on the output data (D0 to D9). This is a very helpful signal that simplifies the synchronization of the measurement equipment or the controlling DSP.
As digital output, DR goes in high impedance state when OEB is asserted to High level as described in the timing diagram page 4.

## REFERENCES AND COMMON MODE CONNECTION

VREFM must be always connected externally.

## Internal reference and common mode

In the default configuration, the ADC operates with its own reference and common mode voltages generated by its internal bandgap. VREFM pin is connected externally to the Analog Ground while VREFP (respectively INCM) is set to its internal voltage of 1.03 V (respectively 0.57 V ). It is recommended to decouple the VREFP in order to minimize low and high frequency noise (refer to Figure 1)

Figure 1 : Internal reference and common mode setting


## External reference and common mode

Each of the voltages VREFM, VREFP and INCM can be fixed externally to better fit to the application needs (Refer to Table íOPERATING CONDITIONSí p2 for min and max values).

The VREFP, VREFM voltages set the analog dynamic at the input of the converter that has a full scale amplitude of 2*(VREFP-VREFM).
In case of analog dynamic lower than 2 Vpp , the best linearity and distortion performance is achieved while increasing the VREFM voltage instead of lowering the VREFP one.

The INCM is the mid voltage of the analog input signal.
It is possible to use an external reference voltage device for specific applications requiring even better linearity, accuracy or enhanced temperature behavior.

Using the STMicroelectronics TS821 or TS4041-1.2 Vref leads to optimum performances when configured as shown on Figure 2.

Figure 2 : External reference setting


At 15 Msps sampling frequency, 1 MHz input frequency and -1dBFS amplitude signal, performances can be improved up to 2 dB on SFDR and 0.3 dB on SINAD. At 50 Msps sampling frequency, 1 MHz input frequency and -1 dBFS amplitude signal, performances can be improved up to 1 dBc on SFDR and 0.6 dB on SINAD.
This can be very helpful for example for multichannel application to keep a good matching among the sampling frequency range.

## DRIVING THE ANALOG INPUT

## Differential inputs

The TSA1002 has been designed to obtain optimum performances when being differentially driven. An RF transformer is a good way to achieve such performances.
Figure 3 describes the schematics. The input signal is fed to the primary of the transformer, while the secondary drives both ADC inputs.

Figure 3 : Differential input configuration with transformer


The common mode voltage of the ADC (INCM) is connected to the center-tap of the secondary of the transformer in order to bias the input signal around this common voltage, internally set to 0.57 V . The INCM is decoupled to maintain a low noise level on this node. Our evaluation board is mounted with a 1:1 ADT1-1WT transformer from Minicircuits. You might also use a higher impedance ratio (1:2 or 1:4) to reduce the driving requirement on the analog signal source. For example, with internal references, each analog input can drive a 1 Vpp amplitude input signal, so the resultant differential amplitude is 2 Vpp .

Figure 4 : AC-coupled differential input


Figure 4 represents the biasing of a differential input signal in AC-coupled differential input configuration. Both inputs VIN and VINB are centered around the common mode voltage, that can be let internal or fixed externally.

Figure 5 shows a DC-coupled configuration with forced INCM to the DC analog input (mid-voltage) while VREFM is connected to ground and VREFP is let internal ( 1 V ); we achieve a 2 Vpp differential amplitude.

Figure 5 : DC-coupled 2Vpp differential analog input


## Single-ended input configuration

The single-ended input configuration of the TSA1002 requires particular biasing and driving. The structure being fully differential, care has to be taken in order to properly bias the inputs in single ended mode. Figure 6 summarizes the link from the differential configuration to the sin-gle-ended one; a wrong configuration is also presented.

- With differential driving, both inputs are centered around the INCM voltage.
- The transition to single-ended configuration implies to connect the unused input (VINB for instance) to the DC component of the single input (Vin) and also to the input common mode in order to be well balanced. The mid-code is achieved at the crossing between VIN and VINB, therefore inputs are conveniently biased.
- Unlikely other structures of converters in which the unused input can be grounded; in our case it will end with unbalanced inputs and saturation of the internal amplifiers leading to a non respect of the output codes.

Figure 6 : Input dynamic range for the various configurations


The applications requiring single-ended inputs can be configured like reported on Figure 7 for an AC-coupled input or on Figure 8 and 9 for a DC-coupled input.

In the case of AC-coupled analog input, the analog inputs Vin and Vinb are biased to the same voltage that is the common mode voltage of the circuit (INCM). The INCM and reference voltages may remain at their internal level but can also be fixed externally.

Figure 7 : AC-coupled Single-ended input


In the case of DC-coupled analog input with 1 V DC signal, the DC component of the analog input set the common mode voltage. As an example figure 8 , INCM is set to the 1V DC analog input while VREFM is connected to ground and VREFP let internal; we achieve a 2 V pp differential amplitude.
Figure 9 describes a configuration for a 1 Vpp analog signal with a 0.5 V DC input. In this case, while VREFP is kept internally at 1 V, VREFM is connected to VINB and INCM externally to 0.5 V ; the dynamic is then 1 Vpp (VREFP-VREFM $=0.5 \mathrm{~V}$ ).

Figure 8 : DC-coupled 2 Vpp analog input


Figure 9 : DC-coupled 1Vpp analog input


Dynamic characteristics, while not being as remarkable as for differential configuration, are still of very good quality. Measurements done at $50 \mathrm{Msps}, 2 \mathrm{MHz}$ input frequency, -1dBFS input level sum up these performances. An SFDR of -64.5 dBc , a SNR of 57.8 dB and an ENOB Full Scale of 9.3bits are achieved.

## Power consumption

The internal architecture of the TSA1002 enables to optimize the power consumption according to the sampling frequency of the application. For this purpose, a resistor is placed between IPOL and the analog Ground pins. The figure 10 sums up the relevant data.
The TSA1002 will combine highest performances and lowest consumption at 50 Msps when Rpol is in the range of $12 \mathrm{k} \Omega$ to $20 \mathrm{k} \Omega$.
At lower sampling frequency, this value of resistor may be changed and the consumption will decrease as well.

Figure 10 : Analog Current consumption vs. Fs According value of Rpol polarization resistance


Linearity, distortion performance towards Clock Duty Cycle variation

The TSA1002 has an outstanding behaviour towards clock duty cycle variation and it may be also reinforced with adjustment of analog current consumption.

## Linearity vs. Duty cycle

Fs=50MSPS; consumption optimized; Fin=1MHz


## Distortion vs. Duty cycle

Fs=50MSPS; consumption optimized; Fin=1MHz


Linearity vs. Duty cycle
Fs=50MSPS; Icca=20mA; Fin=10MHz


Distortion vs. Duty cycle
Fs=50MSPS; Icca=20mA; Fin=10MHz


## Clock input

The quality of your converter is very dependant on your clock input accuracy, in terms of aperture jitter; the use of low jitter crystal controlled oscillator is recommended.

The clock power supplies must be separated from the ADC output ones to avoid digital noise modulation at the output.

It is recommended to keep the circuit clocked, to avoid random states, before applying the supply voltages.

## Layout precautions

To use the ADC circuits in the best manner at high frequencies, some precautions have to be taken for power supplies:

- First of all, the implementation of 4 separate proper supplies and ground planes (analog, digital, internal and external buffer ones) on the PCB is recommended for high speed circuit applications to provide low inductance and low resistance common return.

The separation of the analog signal from the digital part is essential to prevent noise from coupling onto the input signal.

- Power supply bypass capacitors must be placed as close as possible to the IC pins in order to improve high frequency bypassing and reduce harmonic distortion.
- Proper termination of all inputs and outputs is needed; with output termination resistors, the amplifier load will be only resistive and the stability of the amplifier will be improved. All leads must be wide and as short as possible especially for the analog input in order to decrease parasitic capacitance and inductance.
- To keep the capacitive loading as low as possible at digital outputs, short lead lengths of routing are essential to minimize currents when the output changes. To minimize this output capacitance, buffers or latches close to the output pins will relax this constraint.
- Choose component sizes as small as possible (SMD).


## EVAL1002 evaluation board

The characterization of the board has been made with a fully ADC devoted test bench as shown on Figure 11. The analog signal must be filtered to be very pure.

The dataready signal is the acquisition clock of the logic analyzer.

The ADC digital outputs are latched by the 74LCX573 octal buffers.

All characterization measurement has been made with an input amplitude of +0.2 dB for static parameters and -0.5 dB for dynamic parameters.

Figure 11: Analog to Digital Converter characterization bench


Figure 12: TSA1002 Evaluation board schematic


Figure 13: Printed circuit of evaluation board


Printed circuit board - List of components

| Part | Design | Footprint | Part | Design | Footprint | Part | Design | Footprint | P art | Design | Footprint |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Type | ator |  | Type | ator |  | Type | ator |  | Type | ator |  |
| 10 uF | C24 | 1210 | 330pF | c33 | 603 | 470nF | c7 | 805 | AVCC | J12 | FICHE2M M |
| 10 uF | C23 | 1210 | 330 pF | C20 | 603 | $470 n F$ | C 16 | 805 | CLJ/SMB | J4 | SMB/H |
| 10uF | C41 | 1210 | 330 pF | C 8 | 603 | $470 n F$ | C 19 | 805 | AGND | J19 | FICHE2M M |
| 10 uF | C29 | 1210 | 330 pF | C2 | 603 | $470 n F$ | C3 | 805 | DFSB | J9 | FICHE2M M |
| 100pF | C1 | 603 | 330 pF | C5 | 603 | $47 K \Omega$ | R 12 | 603 | DGND | J20 | FICHE2M M |
| 10 nF | C12 | 603 | 330 pF | C 11 | 603 | $47 K \Omega$ | R 14 | 603 | DVCC | J15 | FICHE2M M |
| 10 nF | C39 | 603 | 330 pF | C30 | 603 | $47 K \Omega$ | R 11 | 603 | GndB1 | J22 | FICHE2M M |
| $10 n F$ | C15 | 603 | 330 pF | C 17 | 603 | $47 K \Omega$ | Raj1 | VR5 | GndB2 | J21 | FICHE2M M |
| $10 n F$ | C40 | 603 | 330 pF | C 14 | 603 | $47 K \Omega$ | R 10 | 603 | Mes com mode | J8 | FICHE2M M |
| $10 n F$ | C27 | 603 | 47uF | C36 | CAP | $47 K \Omega$ | R 19 | 603 | OEB | J10 | FICHE2M M |
| $10 n F$ | C4 | 603 | 47uF | C34 | CAP | $47 K \Omega$ | R 13 | 603 | Regl com mode | J7 | FICHE2M M |
| $10 n F$ | C21 | 603 | 47uF | C35 | $C A P$ | $47 K \Omega$ | R 15 | 603 | T2-AT1-1WT | T2 | ADT |
| $10 n F$ | C31 | 603 | 47uF | C42 | CAP | $47 K \Omega$ | R 16 | 603 | T2-AT1-1WT | T1 | ADT |
| $10 n F$ | C6 | 603 | 470nF | C22 | 805 | $47 K \Omega$ | R 17 | 603 | VccB1 | J18 | FICHE2M M |
| 10 nF | C9 | 603 | $470 n F$ | C32 | 805 | $47 K \Omega$ | R 18 | 603 | VDDBUFF3V | J17 | FICHE2M M |
| $10 n F$ | C 18 | 603 | $470 n F$ | C37 | 805 | $50 \Omega$ | R3 | 603 | Vin | J1 | SMB/H |
| $1 K \Omega$ | R2 | 603 | $470 n F$ | C38 | 805 | $50 \Omega$ | R1 | 603 | VrefM | J5 | FICHE2M M |
| 32PIN | J6 | IDC32 | $470 n F$ | C 13 | 805 | 74LCX573 | U3 | TSSOP 20 | VrefP | J2 | FICHE2M M |
| 330pF | C25 | 603 | $470 n F$ | C28 | 805 | 74LCX573 | U2 | TSSOP 20 | TSA 1002 | U1 | TQFP 48 |
| 330pF | C26 | 603 | $470 n F$ | C 10 | 805 | CON2 | J 16 | SIP 2 |  |  |  |

## PACKAGE MECHANICAL DATA

48 PINS - PLASTIC PACKAGE


| Dim. | Millimeters |  |  | Inches |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | Min. | Typ. | Max. | Min. | Typ. | Max. |
| A |  |  | 1.60 |  |  | 0.063 |
| A1 | 0.05 |  | 0.15 | 0.002 |  | 0.006 |
| A2 | 1.35 | 1.40 | 1.45 | 0.053 | 0.055 | 0.057 |
| B | 0.17 | 0.22 | 0.27 | 0.007 | 0.009 | 0.011 |
| C | 0.09 | - | 0.20 | 0.004 |  | 0.008 |
| D |  | 9.00 |  |  | 0.354 |  |
| D1 |  | 7.00 |  |  | 0.276 |  |
| D3 |  | 5.50 |  |  | 0.216 |  |
| e |  | 0.50 |  |  | 0.0197 |  |
| E |  | 9.00 |  |  | 0.354 |  |
| E1 |  | 7.00 |  |  | 0.276 |  |
| E3 |  | 5.50 |  |  | 0.216 |  |
| L | 0.45 | 0.60 | 0.75 | 0.018 | 0.024 | 0.030 |
| $\bigcirc \mathrm{L} 1$ |  | 1.00 |  |  | 0.039 |  |
| K | 0 (min.), 7 (max.) |  |  |  |  |  |

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